

Notice of References Cited	Application/Control No. 10/681,820	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,885,418	04-2005	Matsushita et al.	349/113
	B	US-6,909,479	06-2005	Iijima, Chiyoaki	349/109
	C	US-			
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	F	US-			
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	I	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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